Dielectric property of polycrystalline ZrO$_2$ substituted BaTi$_2$O$_5$ prepared by arc-melting

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Dielectric Property of Polycrystalline ZrO$_2$ Substituted BaTi$_2$O$_5$ Prepared by Arc-Melting

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ZrO$_2$ substituted polycrystalline BaTi$_2$O$_5$, Ba(Ti$_{1-y}$Zr$_y$)$_3$O$_5$ (BT$_y$Z$_z$), was prepared by arc-melting and the dielectric property was investigated by AC impedance spectroscopy. The length of a-axis increased from 1.6895 to 1.6952 nm and that of c-axis increased from 0.9411 to 0.9436 nm with increasing y up to 0.06. The b-axis was almost independent of ZrO$_2$ content. The solubility limit of ZrO$_2$ (y) in BT$_y$Z$_z$ can be 0.06. BT$_y$Z$_z$ had a strong b-axis orientation at y < 0.06. The permittivity of BT$_y$Z$_z$ at y = 0.005 showed the highest peak of 3050 at 725 K and the peak temperature decreased from 750 to 465 K with increasing y from 0 to 0.064. A relaxor-like frequency dependence of permittivity was observed at y > 0.06. [doi:10.2320/matertrans.MRA2007621]

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1. Introduction

Lead-free ferroelectric compounds have been intensively researched in order to accommodate environment issues. BaTiO$_3$ (BT) is a common lead-free ferroelectric material and has a sharp peak of permittivity at a Curie temperature ($T_c = 400$ K).$^{1-5}$ BT based solid solution has been widely studied for many applications, e.g. multilayer ceramic capacitors, to enhance permittivity and/or to broaden the peak temperature. In particular, the effect of ZrO$_2$ substitution on the dielectric property of BT has been investigated because of the chemical similarity but different ionic size between Zr$^{4+}$ and Ti$^{4+}$. It is known that ZrO$_2$ substitution into BT has caused the significant decrease in $T_c$ and increase in permittivity, where ZrO$_2$ can be soluble in BT up to 40 to 50 mol%. Wada et al. reported that ZrO$_2$ substituted BaTi$_3$O$_7$ indicates three types of dielectric behavior with increasing ZrO$_2$ content (x): (1) “normal” phase transition (x < 0.15), where the three phase transitions among rhombohedral, orthorhombic, tetragonal and cubic structure of BT approach each other; (2) “diffuse” phase transition (0.15 < x < 0.25), showing a large broad peak without frequency dependence; (3) “relaxor” phase transition (x > 0.25), exhibiting a characteristic frequency dependence. BaTi$_2$O$_5$ (BT$_2$) has not been paid much attention due to misunderstanding as a common paraelectric compound. Our group has first reported that BT$_2$ single crystal prepared by floating zone (FZ) showed ferroelectricity with a maximum permittivity of 20500 in the b direction at $T_c$ of 750 K.$^{13}$ Akishige et al. also reported that BT$_2$ single crystals had a permittivity maximum of 30000 in the b-axis at $T_c$ of 730 K.$^{14}$ Since single-crystalline materials are difficult and usually costly for production, polycrystalline materials have more advantages for practical applications. We have found that b-axis oriented polycrystalline BT$_2$ can be prepared by arc-melting and the maximum permittivity was 2000 at $T_c$ of 720 K.$^{15}$ The permittivity and $T_c$ can be modified to expand the application of BT$_2$ by substituting Ba$^{2+}$ (A site) or Ti$^{4+}$ (B site) with foreign elements. We have prepared b-axis oriented ferroelectric SrO substituted polycrystalline BT$_2$ by arc-melting where the substitution significantly increased the permittivity of BT$_2$. It is known that the substitution of B-site in BT is also significantly effective to modify the dielectric properties. In the present study, polycrystalline ZrO$_2$ substituted BT$_2$ (BT$_2$Z) were prepared by arc-melting and the effect of ZrO$_2$ substitution on the crystal structure and dielectric property was investigated.

2. Experimental

TiO$_2$, BaCO$_3$, and ZrO$_2$ (99.9% in purity) powders were mixed in a molar ratio of Ba/(Ti + Zr) = 1/2, and the molar fraction (R = Zr/(Ti + Zr)) was changed from 0 to 0.10. The Zr concentration (y) in BT$_2$Z crystal phase was analyzed by EPMA (Electron Probe Microanalysis). The mixed powders were pressed into pellets with 20 mm in diameter at 10 MPa, and calcined at 1223 K for 43 ks in air. The pellets were melted on a water-cooled copper plate by arc-melting in an Ar atmosphere. The crystal phases and orientation were identified by X-ray diffraction (XRD, CuKα). The lattice parameters were calculated from a program based on a least squares analysis. (010) oriented BT$_2$ were cut from an ingot and the dielectric properties were measured using an AC impedance analyzer (Hewlett Packard 4194A) at frequencies (f) from $10^2$ to $10^7$ Hz at temperatures from 293 to 1073 K in air.

3. Results and Discussion

Figure 1 shows the powder XRD patterns of polycrystalline BT$_2$Z in the range of R from 0 to 0.10. No second phase in BT$_2$Z was detected at R < 0.01 (Fig. 1(a)–(c)). At R = 0.03 and 0.05, the main phase was BT$_2$ and a small amount of BT was identified (Fig. 1(d) and (e)). Since BT$_2$ is unstable at a high temperature and tend to decompose into BT and Ba$_6$Ti$_7$O$_{24}$ (B$_6$T$_{17}$), BT might be formed by partial decomposition of BT$_2$ during the solidification. At R = 0.10, phases of BT$_2$, BT and Ba(Ti,Zr)O$_3$ were identified. Figure 2 shows the relationship between the Zr concentration (y) in BT$_2$Z as-grown crystal phase analyzed by EPMA and the molar fraction of raw materials (R = Zr/(Ti + Zr)). The y linearly increased to 0.06 with increas-
ing $R$, and almost constant over $R = 0.07$. Figure 3 depicts the effect of ZrO$_2$ content on the lattice parameters of BT$_2$Z. The lattice parameters of $a$- and $c$-axes increased with increasing ZrO$_2$ content up to $y = 0.060$. The $b$-axis showed almost no change with ZrO$_2$ content. The solubility limit of ZrO$_2$ in BT$_2$Z may be about $y = 0.060$. Since the ionic radius of Zr$^{4+}$ (0.072 nm) is larger than that of Ti$^{4+}$ (0.0605 nm), Zr$^{4+}$ substituted in Ti$^{4+}$ site would enlarge the TiO$_6$ octahedra and result in the increase in lattice parameters.

Figure 4 shows the bulk XRD patterns of polycrystalline BT$_2$Z. The specimens showed a strong orientation of (020) at $y < 0.060$ (Fig. 4(a)–(c)), while the (020) orientation was not significant at $y = 0.064$ (Fig. 4(d)). It is well known that BT$_2$ grows along $b$-direction in a melt. Since the copper plate was cooled by water, BT$_2$ would grow perpendicularly to the copper plate and show (020) orientation along the growth direction. The BT$_2$Z at $y = 0.064$ showed almost no (020) orientation. The increase in second phases of BT and Ba(Ti,Zr)O$_3$ would have caused the non-oriented growth of BT$_2$Z.

Figure 5 shows the fractural SEM image of polycrystalline BT$_2$Z paralleled to the growth direction. Elongated columnar grains about 10 $\mu$m in width and several 100 $\mu$m in length were observed. No grain boundary phase was identified. Beltrán et al. sintered BT$_2$ at 1373 to 1548 K and reported the Cole-Cole plot of BT$_2$ showed only one semicircle and $\varepsilon_t$ value of 130, without contribution from the grain boundary on the dielectric property of BT$_2$. They reported that the $T_c$
was independent of grain size above 1473 K, when the grain size was sufficiently large more than 5 μm. In the present study, the grain size of arc-melted BT2Z was further larger than that of Beltrán et al., and no effect of grain boundary was observed. The dielectric property of BT2Z prepared by arc-melting could be predominantly affected by the substitution.

Figure 6 depicts the Cole-Cole plots of BT2Z at y = 0.008 to 0.060 and 1055 K. The Cole-Cole plot at y = 0.008 showed a single semicircle, implying no contribution from grain boundary and interface. Semicircles were distorted at y = 0.046 and 0.060, which could be caused of the increase in the second phases. The distorted semicircle could be deconvoluted into two semi-circles as reported before.\(^{19}\) The bulk and second phase contributions may be responsible to the semicircle from the original point and the small semicircle in a lower frequency range, respectively. The semicircle from the original point in a high frequency range can be assigned to the bulk BT2 matrix due to a small associated capacitance (1.6 × 10\(^{-11}\) F), while the smaller semicircle in a lower frequency range can be resulted from the interface between the BT2 phase and the second phases (BaTiO\(_3\) and Ba(Ti,Zr)O\(_3\)) due to a lager associated capacitance (5.9 × 10\(^{-9}\) F).

Figure 7 demonstrates the effect of frequency on the imaginary parts of complex impedance (Z’’) and modulus (M’’) of BT2Z at y = 0.008 and 0.060 and 970 K. The frequency dependence of Z’’ and M’’ showed a single peak although the Cole-Cole plot was deconvoluted into two semicircles showing the two electrical regions at y = 0.060. The peak caused of the second phase could be too small to be detected. The peak frequency (f\(_{\text{max}}\)) of the Z’’ should have been in agreement with that of M’’ in theory because f\(_{\text{max}}\) = \(\frac{1}{2\pi R C}\) (R: resistivity, C: capacitance). The discrepancy of these peak frequencies has been often reported.\(^{20,21}\) Some defect structure by the rapid quenching or the second phase by the partial decomposition may cause the discrepancy of the peak frequencies. At y = 0.060 the difference of peak frequencies of Z’’ and M’’ was more pronounced than that at y = 0.008, which may be caused of the increase in the second phase (as shown in Fig. 1).

Figure 8 shows the temperature dependence of electrical conductivity (σ) of BT2Z. The σ of BT2Z had a linear relationship with temperature in the Arrhenius format and decreased with increasing y. The activation energy of BT2Z was 1.40 eV independent of y.

Figure 9 shows the temperature dependence of permittivity at f = 10 k to 1 MHz. The permittivity at y = 0.008 showed the maximum at 710 K independence of frequency (Fig. 9(a)). At y = 0.060, the permittivity showed a relaxor-like behavior (Fig. 9(b)), where the temperature of the permittivity maximum (T\(_m\)) shifted to higher temperatures with increasing frequency. Although numerous relaxor materials have been extensively studied over a long period, the physical nature of relaxor behavior has not been fully understood. To date several reasons have been proposed to explain the relaxor behaviors, such as microscopic composition fluctuation, the nanometer scale polar clusters and the randomly distributed electrical field.\(^{22-24}\) In the present study, the mismatch of Ti\(^{4+}\) and Zr\(^{4+}\) in size might cause local segregation in nano-scale, giving rise to the forming of micropolar clusters and the local electric field.

Figure 10 shows the temperature dependence of permittivity of BT2Z. The permittivity showed a maximum at a temperature (T\(_c\)) and the T\(_c\) decreased with increasing y. The...
maximum permittivity ($\varepsilon_{\text{max}}$) showed the highest value of 3050 at $y = 0.005$. The large permittivity in perovskite materials are usually related to atomic displacements within a non-centro-symmetrical structure. The space group of BT$_2$Z is monoclinic $C2$, whose large permittivity may be caused of the atomic displacements along $b$-axis of Ti atoms located at the center of the TiO$_6$ octahedra. The increase in permittivity may be due to the increase in lattice parameters. Figure 11 demonstrates the effect of $y$ on the $T_c$ and the maximum permittivity ($\varepsilon_{\text{max}}$) at $T_c$. The $\varepsilon_{\text{max}}$ showed the highest value of 3050 at $y = 0.005$, and the permittivity decreased to 600 with further increasing $y$ up to 0.064. The $T_c$ of BT$_2$Z linearly decreased from 750 K at $y = 0$ to 465 K with increasing $y$ up to 0.064.

4. Conclusions

(010) oriented polycrystalline ZrO$_2$ substituted BaTi$_2$O$_5$, Ba(Ti$_{1-y}$Zr$_y$)$_2$O$_5$ (BT$_2$Z) was prepared by arc-melting. The lattice parameters of BT$_2$Z increased from 1.6895 to 1.6952 nm for $a$-axis, 0.9411 to 0.9436 nm for $c$-axis with
increasing $y$ up to 0.060, whereas the length of $b$-axis was almost independent of $\text{ZrO}_2$ content. The solubility limit of $\text{ZrO}_2$ in $\text{BT}_2\text{Z}$ can be $y = 0.060$. With increasing $y$ more than 0.03, the second phases of BT and $\text{Ba(Ti,Zr)O}_3$ appeared. The permittivity increased from 1820 ($\text{BaTi}_2\text{O}_5$) to 3050 at $y = 0.005$, and then decreased with increasing $y$. The $T_c$ of $\text{BT}_2\text{Z}$ linearly decreased from 750 to 465 K with increasing $y$ from 0 to 0.064. The permittivity at $y > 0.06$ showed a relaxor-like behavior.

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